

# SD103ATHRU SD103C

### SMALL SIGNAL SCHOTTKY DIODES

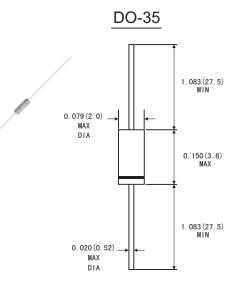
#### **FEATURES**

- · For general purpose applications
- The SD103 series is a Metal-on-silicon junction Schottky barrier device which is protected by a PN junction guard ring. The low forward voltage drop and fast switching make it ideal for protection of MOS devices, steering, biasing, and coupling diodes for fast switching and low logic le vel applications. Other applications are click suppressions, efficient full wavebridges in telephone subsets, and blocking diodes in re chargeable low voltage battery systems.
- These diodes are also available in the MiniMELF case with the type designation LL103A to thru LL103C.
- · High temperature soldering guaranteed:260°C/10 seconds at terminals
- · Component in accordance to RoHS 2011/65/EU

#### MECHANICAL DATA

· Case: DO-35 Glass case

· Weight: Approx. 0.13 gram



Dimensions in inches and (millimeters)

## ABSOLUTE RATINGS (LIMITING VALUES)

	Symbols	Value	Units
SD103A SD103B SD103C	Vrrm Vrrm Vrrm	40 30 20	V
	Ptot	400 1)	mW
	IFSM	15	A
	TJ	125	°C
Storage Temperature Range		-55 to+150	°C
	SD103B	SD103A         VRRM           SD103B         VRRM           SD103C         VRRM           Ptot         Ptot	SD103A   VRRM   40   SD103B   VRRM   30   SD103C   VRRM   20   Ptot   400   15   TJ   125

### **ELECTRICAL CHARACTERISTICS**

(Ratings at 25°C ambient temperature unless otherwise specified)

	Symbols	Min.	Тур.	Max.	Unis
Leakage current at V <sub>R</sub> =30V         SD103A           V <sub>R</sub> =20V         SD103B           V <sub>R</sub> =10V         SD103C	lr lr lr			5 5 5	μΑ μΑ μΑ
Forward voltage drop at I <sub>F</sub> =20mA I <sub>F</sub> =200mA	VF VF			0.37 0.6	V V
Junction Capacitance at V <sub>R</sub> =0V ,f=1MHz	Cı		50		pF
Reverse Recovery time at I <sub>F</sub> =I <sub>R</sub> =50mA,recover to 200mA recover to 0.1 I <sub>R</sub>	trr		10		ns
Thermal resistance, junction to Ambient	RθJA			300 ¹)	°C/W
1) Valid provided that electrodes are kept at ambient temperature					

## RATINGS AND CHARACTERISTICS CURVES SD103A THRU SD103C

Figure 1. Typical variation of fwd.current vs.fwd. Voltage for primary conduction through the schottky barrier

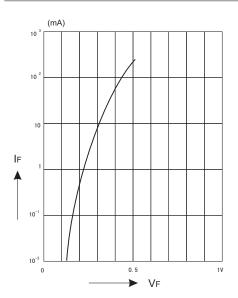
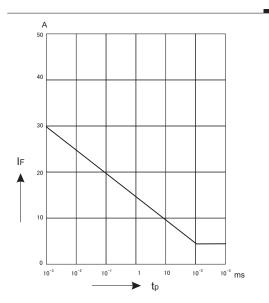


Figure 3. Typical non repetitive forward surge current versus pulse width



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Figure 2. Typical high current forward conduction curve tp=300ms,duty cycle=2%

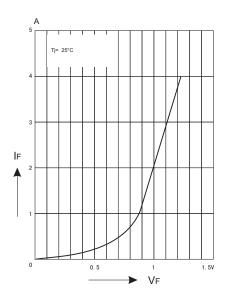
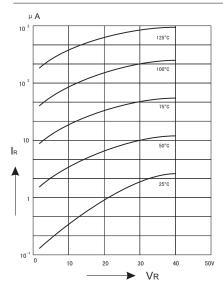


Figure 4. Typical variation of reverse current at various temperatures



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Figure 5. Blocking voltage deration versus temperature at various average forward currents

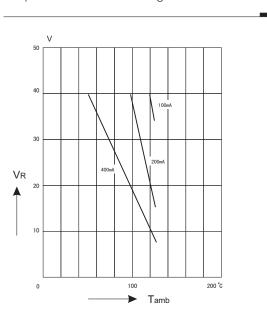
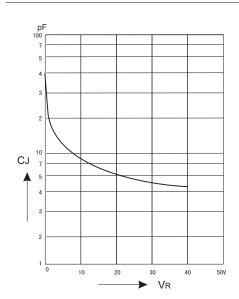


Figure 6. Typical capacitance versus reverse voltage



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